

# **High Speed, Low Noise Quad Operational Amplifier**

**OP-471** 

#### **FEATURES**

•	Excellent Speed		8V/μs Typ
•	Low Noise 11nV/√	Hz	@ 1kHz Max
•	Unity-Gain Stable		
•	High Gain-Bandwidth		6.5MHz Typ
•	Low Input Offset Voltage		0.8mV Max
•	Low Offset Voltage Drift		. 4μV/° C Max
•	High Gain		500V/mV Min
	Outstanding CMR		
	And the Observational Occasion Discourse		

**Industry Standard Quad Pinouts** 

Available in Die Form

#### ORDERING INFORMATION †

T <sub>A</sub> = +25°C		PACKAGE		OPERATING				
ν <sub>os</sub> ΜΑΧ (μV)	CERDIP	PLASTIC	LCC*	EMPERATURE RANGE				
800	OP471AY*	_	OP471ATC/883	MIL				
800	-	_	OP471ARC/883	3 MIL				
800	OP471EY	_	-	IND				
1500	OP471FY	_	_	IND				
1800	_	OP471GP		XIND				
1800	-	OP471GS <sup>††</sup>	_	XIND				

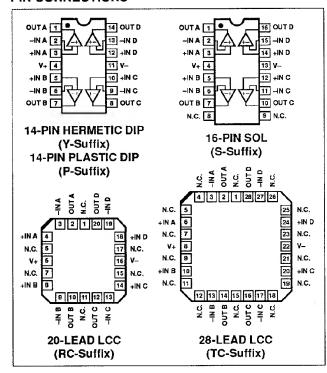
- For devices processed in total compliance to MIL-STD-883, add /883 after part number, Consult factory for 883 data sheet.
- Burn-in is available on commercial and industrial temperature range parts in CerDIP, plastic DIP, and TO-can packages.
- For availability and burn-in information on SO and PLCC packages, contact your local sales office.

#### **GENERAL DESCRIPTION**

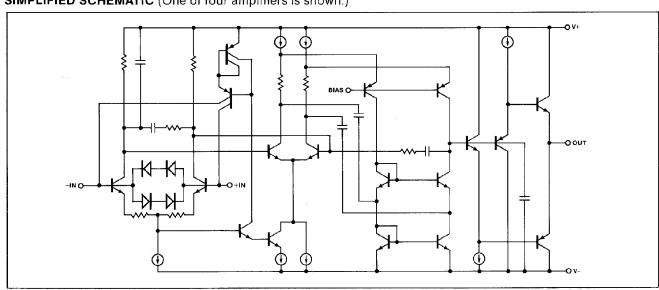
The OP-471 is a monolithic quad op amp featuring low noise, 11nV/√Hz Max @ 1kHz, excellent speed, 8V/μs typical, a gain-bandwidth of 6.5MHz, and unity-gain stability.

The OP-471 has an input offset voltage under 0.8mV and an input offset voltage drift below  $4\mu V/^{\circ}C$ , guaranteed over the full military temperature range. Open loop gain of the OP-471 is over 500,000 into a  $10k\Omega$  load insuring outstanding gain accuracy and linearity. The input bias current is under 25nA

#### PIN CONNECTIONS



#### SIMPLIFIED SCHEMATIC (One of four amplifiers is shown.)



limiting errors due to signal source resistance. The OP-471's CMR of over 105dB and PSRR of under  $5.6\mu V/V$  significantly reduce errors caused by ground noise and power supply fluctuations.

The OP-471 offers excellent amplifier matching which is important for applications such as multiple gain blocks, low-noise instrumentation amplifiers, quad buffers and low-noise active filters.

The OP-471 conforms to the industry standard 14-pin DIP pinout. It is pin compatible with the OP-11, LM148/149, HA4741, RM4156, MC33074, TL084 and TL074 quad op amps and can be used to upgrade systems using these devices.

For applications requiring even lower voltage noise the OP-470, with a voltage density of  $5 \text{nV} / \sqrt{\text{Hz}}$  Max @ 1kHz, is recommended.

#### **ABSOLUTE MAXIMUM RATINGS (Note 1)**

Supply Voltage	±18V
Differential Input Voltage (Note 3)	±1.0V
Differential Input Current (Note 3)	±25mW
Input Voltage	
Output Short-Circuit Duration	
Storage Temperature Range	
P, RC, TC, Y-Package	65°C to +150°C

Lead Temperature Range			
Junction Temperature (Ti		65°C	to +150°C
Operating Temperature F	Range		
OP-471A			to +125°C
OP-471E, OP-471F		–25°C	c to +85°C
OP-471G		–40°C	c to +85°C
PACKAGE TYPE	Θ <sub>jA</sub> (Note 2)	e <sub>jc</sub>	UNITS
14-Pin Hermetic DIP (Y)	94	10	°C/W
14-Pin Plastic DIP (P)	76	33	°C/W
20-Contact LCC (RC)	78	30	°C/W
28-Contact LCC (TC)	70	28	°C/W
16-Pin SOL (S)	88	23	°C/W

#### NOTES:

- Absolute maximum ratings apply to both DICE and packaged parts, unless otherwise noted.
- 9<sub>jA</sub> is specified for worst case mounting conditions, i.e., 9<sub>jA</sub> is specified for device in socket for CerDIP, P-DIP, and LCC packages; e<sub>jA</sub> is specified for device soldered to printed circuit board for SOL package.
- The OP-471's inputs are protected by back-to-back diodes. Current limiting resistors are not used in order to achieve low noise performance. If differential voltage exceeds ±1.0V, the input current should be limited to ±25mA.

### **ELECTRICAL CHARACTERISTICS** at $V_S = \pm 15V$ , $T_A = 25^{\circ}C$ , unless otherwise noted.

			OI	P-471A	/E	(	P-471	F		OP-	471G	
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Input Offset Voltage	Vos		-	0.25	0.8	_	0.5	1.5	-	1.0	1.8	mV
Input Offset Current	Ios	V <sub>CM</sub> = 0V	_	4	10		7	20	_	12	30	nA
Input Bias Current	I <sub>B</sub>	V <sub>CM</sub> = 0V	_	7	25	_	15	50	_	25	60	nA
Input Noise Voltage	e <sub>np-p</sub>	0.1Hz to 10Hz (Note 1)	_	250	500		250	500	_	250	500	nV <sub>p-p</sub>
		f <sub>O</sub> = 10Hz	_	9	16	_	9	16	_	9	16	
Input Noise		$f_O = 100Hz$	_	7	12	_	7	<b>1</b> 2	_	7	12	->// /1/=
Voltage Density	e <sub>n</sub>	f <sub>O</sub> – 1kHz (Note 2)		6.5	11	_	6.5	11	_	6.5	11	nV/√ Hz
	i <sub>n</sub>	f <sub>O</sub> = 10Hz	_	1.7	_	_	1.7	_		1.7		
Input Noise		f <sub>O</sub> – 100Hz	_	0.7	_	_	0.7	_	_	0.7	_	
Current Density		f <sub>O</sub> = 1kHz		0.4	_		0.4	_		0.4		
Large-Signal	^	$V_O = \pm 10V$	500	700	_	300	500		300	500	_	V/mV
Voltage Gain	$A_{VO}$	$R_L = 10k\Omega$ $R_L = 2k\Omega$	350	550	_	175	275	_	175	275	_	V/IIIV
In a set Vallage December	IMP											
Input Voltage Range	IVR	(Note 3)	±11	±12		±11	±12		± 11	± 12		V
Output Voltage Swing	Vo	$R_L \ge 2k\Omega$	±12	±13		±12	±13		± 12	± 13		V
Common-Mode Rejectio	n CMR	$V_{CM} = \pm 11V$	105	120		95	115		95	115	_	dB
Power Supply Rejection Ratio	PSRR	$V_S = +4.5V \text{ to } +18V$	_	1	5.6	_	5.6	17.8	_	5.6	17.8	μV/V
Slew Rate	SR		6.5	8	_	6.5	8		6.5	8	_	V/μs

# **ELECTRICAL CHARACTERISTICS** at $V_S = \pm 15 V$ , $T_A = 25 ^{\circ} C$ , unless otherwise noted. (Continued)

			OP-471A/E		OP-471F			OP-471G				
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Supply Current (All Amplifiers)	I <sub>SY</sub>	No Load	_	9.2	11		9.2	11	_	9.2	11	mA
Gain-Bandwidth Product	GBW	A <sub>V</sub> = +10	_	6.5	_		6.5		_	6.5	_	MHz
Channel Separation	cs	$V_{O} = 20V_{p-p}$ $f_{O} = 10Hz \text{ (Note 1)}$	125	150		125	150	_	125	150	_	dB
Input Capacitance	CIN		_	2.6		_	2.6	_	_	2.6	_	pF
Input Resistance Differential-Mode	R <sub>IN</sub>		_	1,1		_	1.1	_	_	1.1	_	MΩ
Input Resistance Common-Mode	R <sub>INCM</sub>		_	11	_	_	11	_	_	11	_	GΩ
		$A_V = +1$										
Settling Time	t <sub>s</sub>	to 0.1%	_	4.5	_		4.5	_	_	4.5	_	$\mu$ S
		to 0.01%	_	7.5	_		7.5	_	_	7.5	_	

#### NOTES:

- 1. Guaranteed but not 100% tested.
- 2. Sample tested.
- 3. Guaranteed by CMR test.

# **ELECTRICAL CHARACTERISTICS** at $V_S = \pm 15V$ , $-55^{\circ}C \le T_A \le 125^{\circ}C$ for OP-471A, unless otherwise noted.

			OP-471A					
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS		
Input Offset Voltage	Vos		_	0.4	1.2	mV		
Average Input Offset Voltage Drift	TCVos			1	4	μV/°C		
Input Offset Current	os	V <sub>CM</sub> = 0V	_	6	20	nA		
Input Bias Current	I <sub>B</sub>	$V_{CM} = 0V$	_	16	50	nA		
Large-Signal Voltage Gain	A <sub>VO</sub>	$V_{O} = \pm 10V$ $R_{L} = 10k\Omega$ $R_{L} = 2k\Omega$	375 250	500 350	<u>-</u>	V/mV		
Input Voltage Range	IVR	(Note 1)	±11	±12	_	٧		
Output Voltage Swing	Vo	$R_L \ge 2k\Omega$	±12	±13	_	V		
Common-Mode Rejection	CMR	$V_{CM} = \pm 11 V$	100	<b>1</b> 15	_	dB		
Power Supply Rejection Ratio	PSRR	$V_{S} = \pm 4.5 V$ to $\pm 18 V$	_	5.6	10	μV/V		
Supply Current (All Amplifiers)	I <sub>SY</sub>	No Load	_	9.3	11	mA		

#### NOTE:

<sup>1.</sup> Guaranteed by CMR test.

OP-471

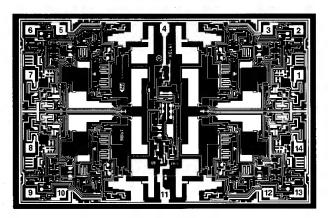
**ELECTRICAL CHARACTERISTICS** at  $V_S = \pm 15V$ ,  $-25^{\circ}C \le T_A \le +85^{\circ}C$  for OP-471E/F,  $-40^{\circ}C \le T_A \le +85^{\circ}C$  for OP-471G, unless otherwise noted.

			OP-471E		OP-471F			OP-471G				
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Input Offset Voltage	Vos		_	0.3	1.1		0.6	2.0	_	1.2	2.5	mV
Average Input Offset Voltage Drift	TCVos		_	1	4	_	2	7	_	4	_	μV/°C
Input Offset Current	os	V <sub>CM</sub> = 0V	_	5	20	_	8	40	_	20	50	nA
Input Bias Current	l <sub>B</sub>	$V_{CM} = 0V$	_	13	50	_	25	70	_	40	75	nA
Large-Signal Voltage Gain	A <sub>vo</sub>	$V_{O} = \pm 10V$ $R_{L} = 10k\Omega$ $R_{L} = 2k\Omega$	375 250	600 400		200 125	400 200		200 125	400 200	_	V/mV
Input Voltage Range	IVR	(Note 1)	± 11	±12	-	±11	±12	_	±11	± 12	_	٧
Output Voltage Swing	V <sub>O</sub>	$R_L \ge 2k\Omega$	± 12	±13	<u>·</u>	± 12	±13	_	± 12	± 13		V
Common-Mode Rejection	CMR	$V_{CM} = \pm 11V$	100	115	_	90	110		90	110	_	dВ
Power Supply Rejection Ratio	PSRR	$V_{\rm S} = \pm 4.5 {\rm V} \ {\rm to} \ \pm 18 {\rm V}$	_	3.2	10	_	18	31.6		18	31.6	μV/V
Supply Current (All Amplifiers)	I <sub>SY</sub>	No Load	_	9.3	11	_	9.3	11	_	9.3	11	mA

## NOTE:

<sup>1.</sup> Guaranteed by CMR test.

## **DICE CHARACTERISTICS**



DIE SIZE 0.163  $\times$  0.106 inch, 17,278 sq. mils (4.14  $\times$  2.69 mm, 11.14 sq. mm)

- 1. OUT A
- 2. -IN A
- 3. +IN A
- 4. V+
- 5. +IN B
- 6. -IN B
- 7. OUT B
- 8. OUT C 9. -IN C
- 10. +IN C
- 11. V-
- 12. + IN D
- 13. -IN D 14. OUT D

## **WAFER TEST LIMITS** at $V_S = \pm 15V$ , $T_A = 25^{\circ}C$ , unless otherwise noted.

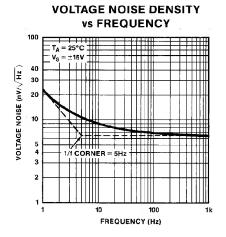
			OP-471GBC	
PARAMETER	SYMBOL	CONDITIONS	LIMIT	UNITS
Input Offset Voltage	Vos		1.5	mV MAX
Input Offset Current	Ios	V <sub>CM</sub> = 0V	20	nA MAX
Input Bias Current	I <sub>B</sub>	$V_{CM} = oV$	50	nA MAX
Large-Signal Voltage Gain	A <sub>VO</sub>	$V_O = \pm 10V$ $R_L = 10k\Omega$ $R_L = 2k\Omega$	300 175	V/mV MIN
Input Voltage Range	IVR	Note 1	±11	V MIN
Output Voltage Swing	v <sub>o</sub>	$R_L \ge 2k\Omega$	±12	V MIN
Common-Mode Rejection	CMR	V <sub>CM</sub> – ±11V	95	dB MIN
Power Supply Rejection Ratio	PSRR	$V_{S} = \pm 4.5 V \text{ to } \pm 18 V$	17.8	$\mu$ V/V MAX
Slew Rate	SR	- 11 - 21	6.5	V/μs MIN
Supply Current (All Amplifiers)	I <sub>SY</sub>	No Load .	11	mA MAX

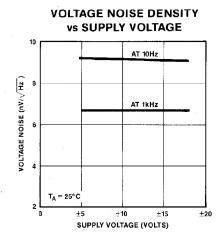
#### NOTES:

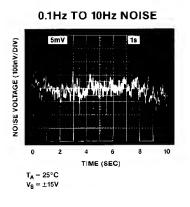
Electrical tests are performed at wafer probe to the limits shown. Due to variations in assembly methods and normal yield loss, yield after packaging is not guaranteed for standard product dice. Consult factory to negotiate specifications based on dice lot qualification through sample lot assembly and testing.

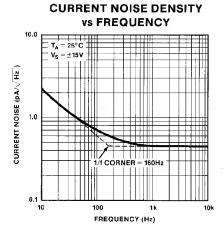
<sup>1.</sup> Guaranteed by CMR test.

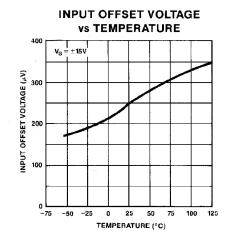
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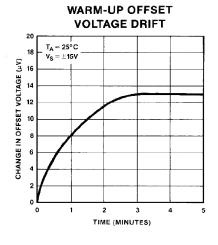


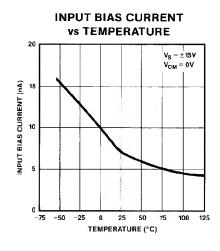


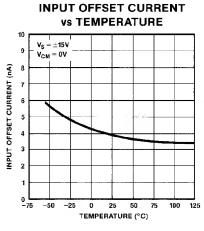


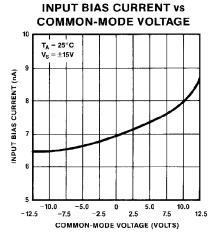




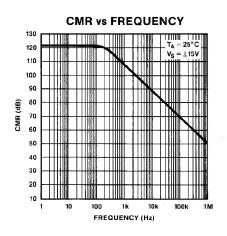


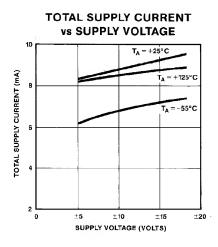


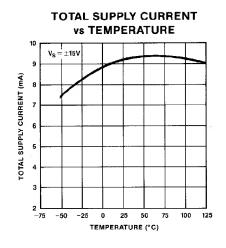


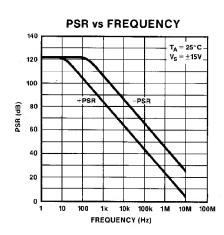


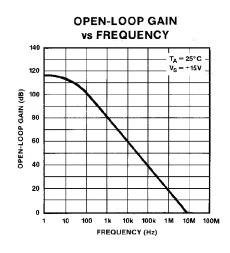
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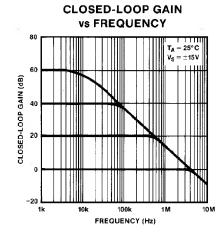


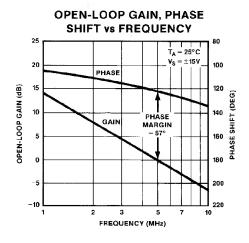


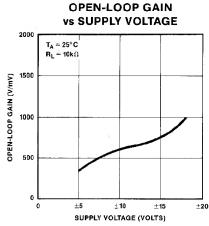


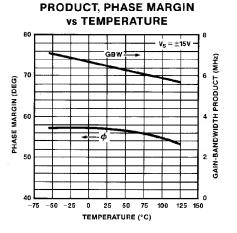






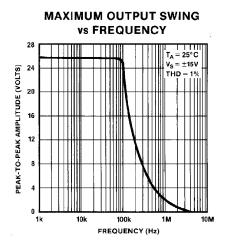






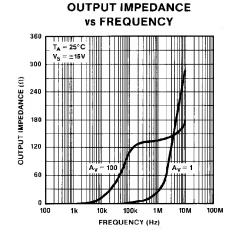
**GAIN-BANDWIDTH** 

#### TYPICAL PERFORMANCE CHARACTERISTICS

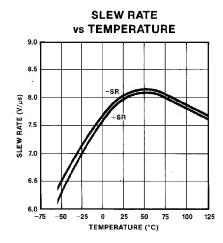


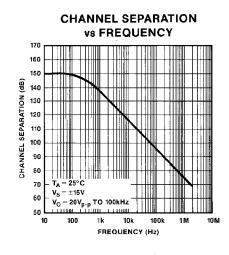
**VOLTAGE vs** LOAD RESISTANCE 20 TA = 25°C 18  $V_S = \pm 15V$ 16 MAXIMUM OUTPUT (VOLTS) 14 ÓSÍTIVE 12 NEGATIVE 10 8 2 0 100 1k 10k LOAD RESISTANCE (f)

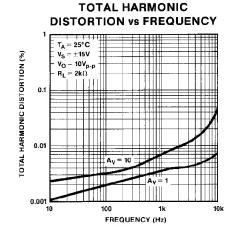
**MAXIMUM OUTPUT** 

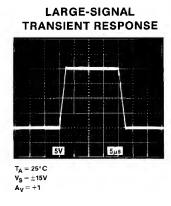


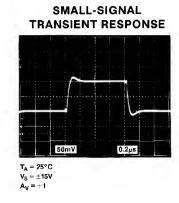
**CLOSED-LOOP** 



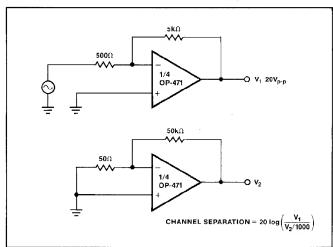




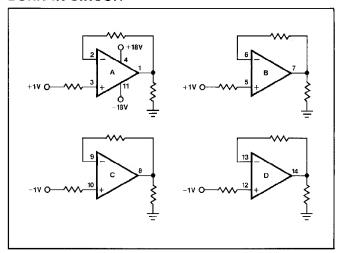




#### **CHANNEL SEPARATION TEST CIRCUIT**



#### **BURN-IN CIRCUIT**



#### **APPLICATIONS INFORMATION**

### **VOLTAGE AND CURRENT NOISE**

The OP-471 is a very low-noise quad op amp, exhibiting a typical voltage noise of only  $6.5 \, \text{nV/}\sqrt{\,\text{Hz}\,}$  @ 1kHz. The low noise characteristic of the OP-471 is in part achieved by operating the input transistors at high collector currents since the voltage noise is inversely proportional to the square root of the collector current. Current noise, however, is directly proportional to the square root of the collector current. As a result, the outstanding voltage noise performance of the OP-471 is gained at the expense of current noise performance which is typical for low noise amplifiers.

To obtain the best noise performance in a circuit it is vital to understand the relationship between voltage noise  $(e_n)$ , current noise  $(i_n)$ , and resistor noise  $(e_t)$ .

#### **TOTAL NOISE AND SOURCE RESISTANCE**

The total noise of an op amp can be calulated by:

$$E_n = \sqrt{(e_n)^2 + (i_n R_S)^2 + (e_t)^2}$$

where:

E<sub>n</sub> = total input referred noise

e<sub>n</sub> = op amp voltage noise

in = op amp current noise

et = source resistance thermal noise

 $R_S$  = source resistance

The total noise is referred to the input and at the output would be amplified by the circuit gain.

Figure 1 shows the relationship between total noise at 1kHz and source resistance. For  $R_S\!<\!1k\Omega$  the total noise is domi-

FIGURE 1: Total Noise vs Source Resistance (Including Resistor Noise) at 1kHz

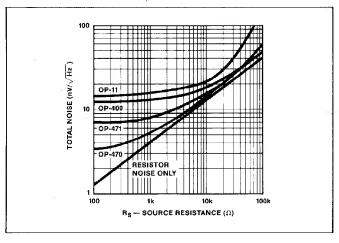
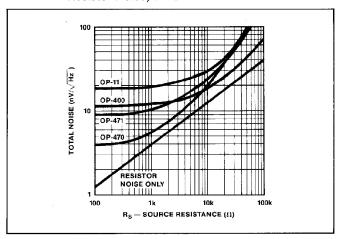


FIGURE 2: Total Noise vs Source Resistance (Including Resistor Noise) at 10Hz



## 0P-471

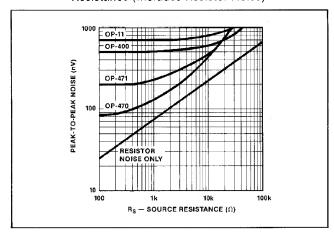
nated by the voltage noise of the OP-471. As R<sub>S</sub> rises above 1k $\Omega$ , total noise increases and is dominated by resistor noise rather than by voltage or current noise of the OP-471. When R<sub>S</sub> exceeds 20k $\Omega$ , current noise of the OP-471 becomes the major contributor to total noise.

Figure 2 also shows the relationship between total noise and source resistance, but at 10Hz. Total noise increases more quickly than shown in Figure 1 because current noise is inversely proportional to the square root of frequency. In Figure 2, current noise of the OP-471 dominates the total noise when  $R_{\rm S} > 5 k\Omega.$ 

From Figures 1 and 2 it can be seen that to reduce total noise, source resistance must be kept to a minimum. In applications with a high source resistance, the OP-400, with lower current noise than the OP-471, will provide lower total noise.

Figure 3 shows peak-to-peak noise versus source resistance over the 0.1Hz to 10Hz range. Once again, at low values of R<sub>S</sub>,

FIGURE 3: Peak-To-Peak Noise (0.1Hz To 10Hz) vs Source Resistance (Includes Resistor Noise)



the voltage noise of the OP-471 is the major contributor to peak-to-peak noise. Current noise becomes the major contributor as  $R_{\rm S}$  increases. The crossover point between the OP-471 and the OP-400 for peak-to-peak noise is at  $R_{\rm S}=17 k\Omega$ .

The OP-470 is a lower noise version of the OP-471, with a typical noise voltage density of  $3.2 \text{nV}/\sqrt{\text{Hz}}$  @ 1kHz. The OP-470 offers lower offset voltage and higher gain than the OP-471, but is a slower speed device, with a slew rate of  $2 \text{V}/\mu \text{s}$  compared to a slew rate of  $8 \text{V}/\mu \text{s}$  for the OP-471.

For reference, typical source resistances of some signal sources are listed in Table I.

TABLE I

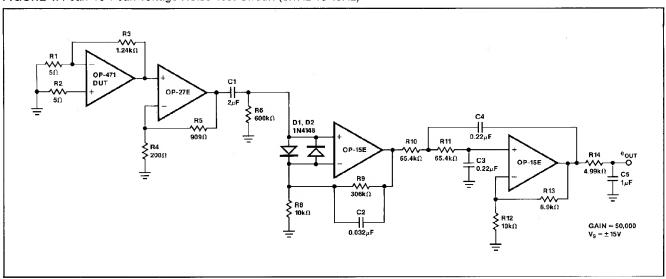
DEVICE	SOURCE IMPEDANCE	COMMENTS
Strain gauge	<500Ω	Typically used in low-frequency applications.
Magnetic tapehead	<1500Ω	Low I <sub>B</sub> very important to reduce self-magnetization problems when direct coupling is used. OP-471 I <sub>B</sub> can be neglected.
Magnetic phonograph cartridges	<1500Ω	Similar need for low I <sub>B</sub> in direct coupled applications. OP-471 will not introduce any self-magnetization problem.
Linear variable differential transformer	<1500Ω	Used in rugged servo-feedback applications. Bandwidth of interest is 400Hz to 5kHz.

For further information regarding noise calculations, see "Minimization of Noise in Op-Amp Applications", Application Note AN-15.

#### NOISE MEASUREMENTS — PEAK-TO-PEAK VOLTAGE NOISE

The circuit of Figure 4 is a test setup for measuring peak-topeak voltage noise. To measure the 500nV peak-to-peak

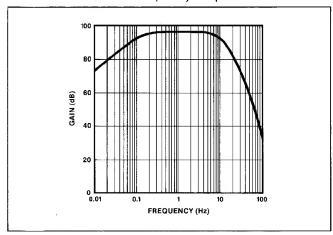
FIGURE 4: Peak-To-Peak Voltage Noise Test Circuit (0.1Hz To 10Hz)



noise specification of the OP-471 in the 0.1Hz to 10Hz range, the following precautions must be observed:

- The device has to be warmed-up for at least five minutes. As shown in the warm-up drift curve, the offset voltage typically changes 13μV due to increasing chip temperature after power-up. In the 10-second measurement interval, these temperature-induced effects can exceed tensof-nanovolts.
- For similar reasons, the device has to be well-shielded from air currents. Shielding also minimizes thermocouple effects.
- Sudden motion in the vicinity of the device can also "feedthrough" to increase the observed noise.

FIGURE 5: 0.1Hz To 10Hz Peak-To-Peak Voltage Noise Test Circuit Frequency Response



- 4. The test time to measure 0.1Hz-to-10Hz noise should not exceed 10 seconds. As shown in the noise-tester frequency-response curve of Figure 5, the 0.1Hz corner is defined by only one pole. The test time of 10 seconds acts as an additional pole to eliminate noise contribution from the frequency band below 0.1Hz.
- 5. A noise-voltage-density test is recommended when measuring noise on a large number of units. A 10Hz noise-voltage-density measurement will correlate well with a 0.1Hz-to-10Hz peak-to-peak noise reading, since both results are determined by the white noise and the location of the 1/f corner frequency.
- Power should be supplied to the test circuit by well bypassed low-noise supplies, e.g. batteries. These will minimize output noise introduced through the amplifier supply pins.

#### NOISE MEASUREMENT — NOISE VOLTAGE DENSITY

The circuit of Figure 6 shows a quick and reliable method of measuring the noise voltage density of quad op amps. Each individual amplifier is series-connected and is in unity-gain, save the final amplifier which is in a noninverting gain of 101. Since the ac noise voltages of each amplifier are uncorrelated, they add in rms fashion to yield:

$$e_{OUT} = 101 \left( \sqrt{e_{nA}^2 + e_{nB}^2 + e_{nC}^2 + e_{nD}^2} \right)$$

The OP-471 is a monolithic device with four identical amplifiers. The noise voltage density of each individual amplifier will match, giving:

$$e_{OUT} = 101 (\sqrt{4e_n^2}) = 101 (2e_n)$$

FIGURE 6: Noise Voltage Density Test Circuit

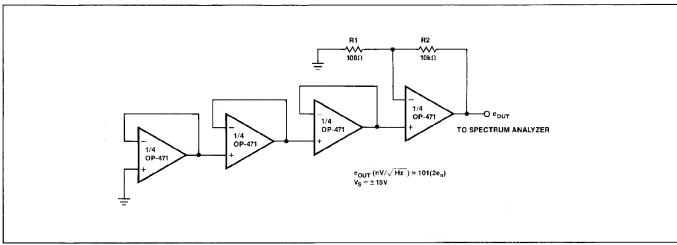
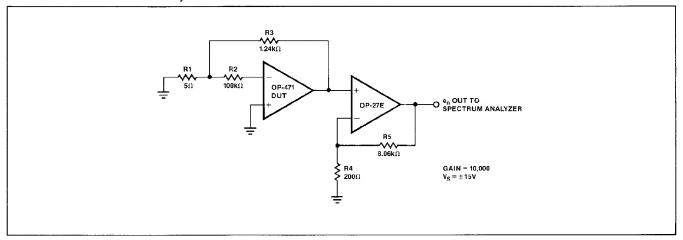


FIGURE 7: Current Noise Density Test Circuit



#### **NOISE MEASUREMENT — CURRENT NOISE DENSITY**

The test circuit shown in Figure 7 can be used to measure current noise density. The formula relating the voltage output to current noise density is:

$$i_n = \frac{\sqrt{\left(\frac{e_{nOUT}}{G}\right)^2 - \left(40nV/\sqrt{Hz}\right)^2}}{R_S}$$

where:

G = gain of 10000 $R_S = 100k\Omega$  source resistance

# CAPACITIVE LOAD DRIVING AND POWER SUPPLY CONSIDERATIONS

The OP-471 is unity-gain stable and is capable of driving large capacitive loads without oscillating. Nonetheless, good supply bypassing is highly recommended. Proper supply bypassing reduces problems caused by supply line noise and improves the capacitive load driving capability of the OP-471.

In the standard feedback amplifier, the op amp's output resistance combines with the load capacitance to form a low-pass filter that adds phase shift in the feedback network and reduces stability. A simple circuit to eliminate this effect is shown in Figure 8. The added components, C1 and R3, decouple the amplifier from the load capacitance and provide additional stability. The values of C1 and R3 shown in Figure 8 are for load capacitances of up to 1000pF when used with the OP-471.

In applications where the OP-471's inverting or noninverting inputs are driven by a low source impedance (under  $100\Omega$ ) or connected to ground, if V+ is applied before V-, or when V- is disconnected, excessive parasitic currents will flow. Most

FIGURE 8: Driving Large Capacitive Loads

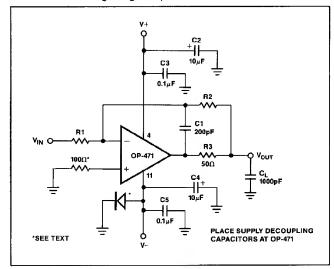
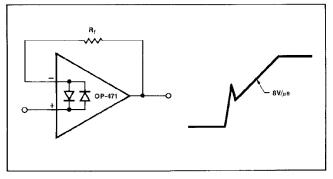


FIGURE 9: Pulsed Operation



applications use dual tracking supplies and with the device supply pins properly bypassed, power-up will not present a problem. A source resistance of at least  $100\Omega$  in series with all inputs (Figure 8) will limit the parasitic currents to a safe level if V— is disconnected. It should be noted that any source resistance, even  $100\Omega$ , adds noise to the circuit. Where noise is required to be kept at a minimum, a germanium or Schottky diode can be used to clamp the V— pin and eliminate the parasitic current flow instead of using series limiting resistors. For most applications, only one diode clamp is required per board or system.

#### **UNITY-GAIN BUFFER APPLICATIONS**

When  $R_f \leq 100\Omega$  and the input is driven with a fast, large-signal pulse (>1V), the output waveform will look as shown in Figure 9.

During the fast feedthrough-like portion of the output, the input protection diodes effectively short the output to the input, and a current, limited only by the output short-circuit protection, will be drawn by the signal generator. With  $R_f\!\geq\!500\Omega,$  the output is capable of handling the current requirements (I\_  $\!\leq\!20\text{mA}$  at 10V); the amplifier will stay in its active mode and a smooth transition will occur.

When  $R_f\!>\!3k\Omega,$  a pole created by  $R_f$  and the amplifier's input capacitance (2.6pF) creates additional phase shift and reduces phase margin. A small capacitor (20 to 50pF) in parallel with  $R_f$  helps eliminate this problem.

#### **APPLICATIONS**

#### LOW NOISE AMPLIFIER

A simple method of reducing amplifier noise by paralleling amplifiers is shown in Figure 10. Amplifier noise, depicted in Figure 11, is around  $5 \text{nV}/\sqrt{\text{Hz}}$  @ 1kHz (R.T.I.). Gain for each paralleled amplifier and the entire circuit is 100. The  $200\Omega$  resistors limit circulating currents and provide an effective output resistance of  $50\Omega$ . The amplifier is stable with a 10nF capacitive load and can supply up to 30mA of output drive.

#### HIGH-SPEED DIFFERENTIAL LINE DRIVER

The circuit of Figure 12 is a unique line driver widely used in professional audio applications. With  $\pm$  18V supplies the line driver can deliver a differential signal of  $30V_{p-p}$  into a  $1.5k\Omega$  load. The output of the differential line driver looks exactly like a transformer. Either output can be shorted to ground without changing the circuit gain of 5, so the amplifier can easily be set for inverting, noninverting, or differential operation. The line driver can drive unbalanced loads, like a true transformer.

#### **HIGH OUTPUT AMPLIFIER**

The amplifier shown in Figure 13 is capable of driving  $20V_{p-p}$  into a floating  $400\Omega$  load. Design of the amplifier is based on a bridge configuration. A1 amplifies the input signal and drives the load with the help of A2. Amplifier A3 is a unity-gain inverter which drives the load with help from A4. Gain of the high output amplifier with the component values shown is 10, but can easily be changed by varying R1 or R2.

FIGURE 10: Low Noise Amplifier

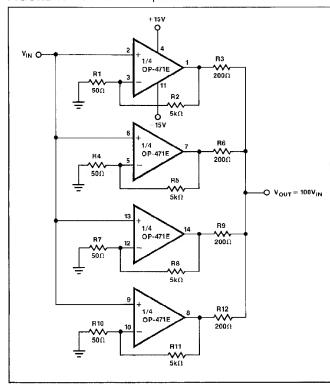


FIGURE 11: Noise Density of Low Noise Amplifier, G = 100

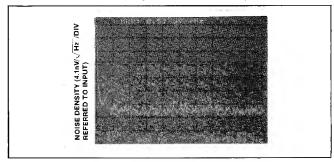


FIGURE 12: High-Speed Differential Line Driver

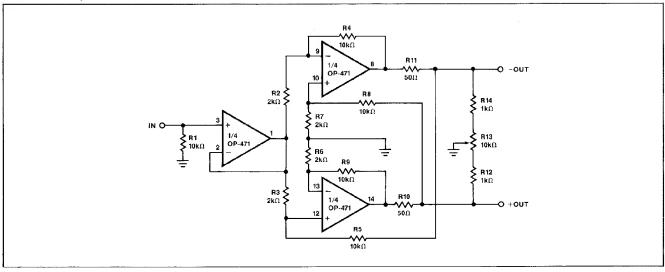
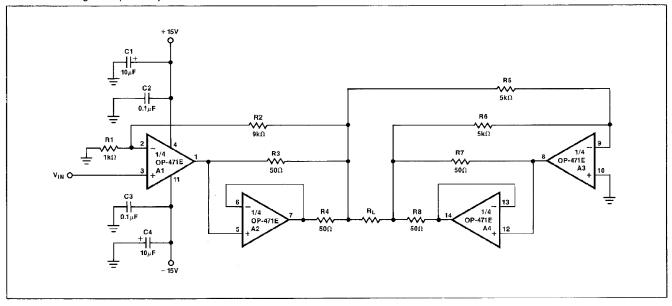


FIGURE 13: High Output Amplifier



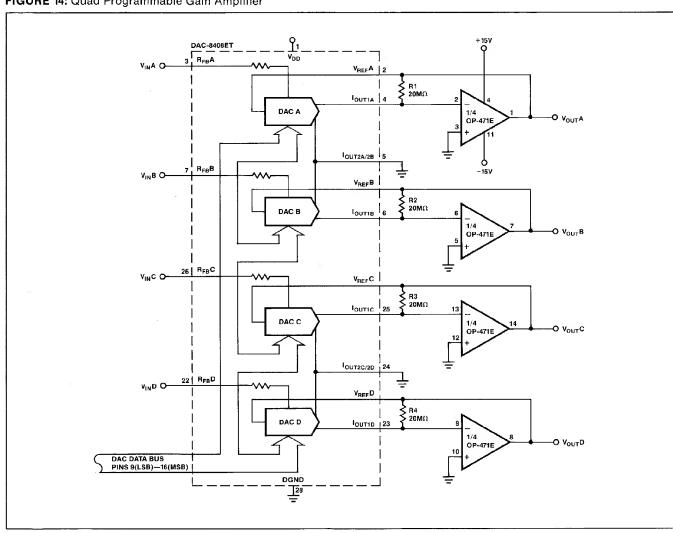
#### **QUAD PROGRAMMABLE GAIN AMPLIFIER**

The combination of the quad OP-471 and the DAC-8408, a quad 8-bit CMOS DAC, creates a space-saving quad programmable gain amplifier. The digital code present at the DAC, which is easily set by a microprocessor, determines the ratio between the fixed DAC feedback resistor and the impedance the DAC ladder presents to the op amp feedback loop. Gain of each amplifier is:

$$\frac{V_{OUT}}{V_{IN}} = -\,\frac{256}{n} \ , \label{eq:Vout}$$

where n equals the decimal equivalent of the 8-bit digital code present at the DAC. If the digital code present at the DAC consists of all zeros, the feedback loop will be open causing the op amp output to saturate. The  $20 M\Omega$  resistors placed in parallel with the DAC feedback loop eliminates this problem with a very small reduction in gain accuracy.

FIGURE 14: Quad Programmable Gain Amplifier

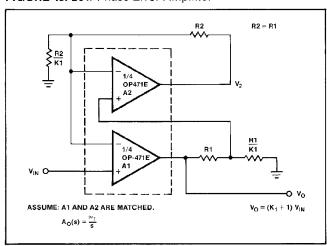


#### LOW PHASE ERROR AMPLIFIER

The simple amplifier depicted in Figure 15 utilizes monolithic matched operational amplifiers and a few resistors to substantially reduce phase error compared to conventional amplifier designs. At a given gain, the frequency range for a specified phase accuracy is over a decade greater than for a standard single op amp amplifier.

The low phase error amplifier performs second-order frequency compensation through the response of op amp A2 in the feedback loop of A1. Both op amps must be extremely well matched in frequency response. At low frequencies, the A1 feedback loop forces  $V_2/(K1+1)=V_{IN}$ . The A2 feedback loop forces  $V_0/(K1+1)=V_2/(K1+1)$  yielding an overall transfer function of  $V_0/V_{IN}=K1+1$ . The DC gain is deter-

FIGURE 15: Low Phase Error Amplifier



mined by the resistor divider at the output,  $V_O$ , and is not directly affected by the resistor divider around A2. Note, that like a conventional single op amp amplifier, the DC gain is set by resistor ratios only. Minimum gain for the low phase error amplifier is 10.

Figure 16 compares the phase error performance of the low phase error amplifier with a conventional single op amp amplifier and a cascaded two-stage amplifier. The low phase error amplifier shows a much lower phase error, particularly for frequencies where  $\omega/\beta\omega_{\rm T}<0.1$ . For example, phase error of  $-0.1^{\circ}$  occurs at  $0.002~\omega/\beta\omega_{\rm T}$  for the single op amp amplifier, but at  $0.11~\omega/\beta\omega_{\rm T}$  for the low phase error amplifier.

For more detailed information on the low phase error amplifier, see Application Note AN-107.

FIGURE 16: Phase Error Comparison

